

**Search Notes**

Application/Control No.

10/574,668

Examiner

LEE NGUYEN

Applicant(s)/Patent under  
Reexamination

IKEDA ET AL.

Art Unit

2618

**SEARCHED**

Class	Subclass	Date	Examiner
455	567	11/14/2007	LN
	518		
	519		
340	7.58		
	7.59		
	7.6		
	7.62		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
455	566	11/21/2007	LN
340	7.58		
SEE SEARCH HISTORY		11/21/2007	LN

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (USPG-PUB; USPAT; JPO; EPO; DERWENT) SEE SEARCH HISTORY	11/14/2007	LN